Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/698,622	JONG ET AL.	
Examiner	Art Unit	
Emmanuel Bayard	2611	

	SEARCHED					
Class	Subclass	Date	Examiner			
375	224	6/23/06	IN			
	778	1	1			
	355					
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775	375	6/23/06	KB			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
325	277	6/2406	xik	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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